

AONR66820

80V N-Channel AlphaSGT2 ™

General Description

- Trench Power MOSFET AlphaSGT2TM technology 80V
- Low $R_{DS(ON)}$
- Excellent Q_g x R_{DS(ON)} Product (FOM)
- Pb-Free lead Plating, RoHS 2.0 and Halogen-Free Compliant
- Spike Optimized Process

Applications

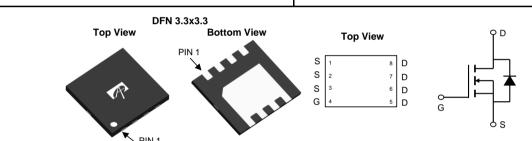
- Full Bridge MOSFET for isolated DC/DC converter
- DC/DC converters

Product Summary

 $\begin{array}{ll} V_{DS} & 80V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 50A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 7.2 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 8V) & < 8.8 m\Omega \end{array}$

100% UIS Tested 100% Rg Tested





Orderable Part Number Package Type		Form	Minimum Order Quantity		
AONR66820	DFN 3.3x3.3	Tape & Reel	3000		

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V_{DS}	80	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain	T _C =25°C		50		
Current G	T _C =100°C	I _D	50	А	
Pulsed Drain Current ^Ċ		I _{DM}	150	\neg	
Continuous Drain	T _A =25°C		17	Α Α	
Current	T _A =70°C	IDSM	14		
Avalanche Current ^C		I _{AS}	35	А	
Avalanche energy	L=0.1mH	E _{AS}	61	mJ	
	T _C =25°C	Ь	104	10/	
Power Dissipation ^B	T _C =100°C	P _D	41	W	
	T _A =25°C	Ь	4.1	10/	
Power Dissipation ^A	T _A =70°C	— P _{DSM}	2.6	W	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	В	25	30	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	$R_{ hetaJA}$	50	60	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.0	1.2	°C/W	



Electrical Characteristics (T_{.I}=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		80			V
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =80V, V_{GS} =0V				1	
			T _J =55°C			5	μA
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS, I_D}=250\mu A$		2.9	3.5	4.1	V
	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =17A			6	7.2	mΩ
R _{DS(ON)}			T _J =125°C		10.2	12.2	
		$V_{GS}=8V$, $I_D=17A$			7	8.8	mΩ
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=17A$	V_{DS} =5V, I_{D} =17A		47		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V			0.72	1	V
I _S	Maximum Body-Diode Continuous Current ^G					50	Α
DYNAMI	C PARAMETERS		•		-		-
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =40V, f=1MHz			1950		pF
Coss	Output Capacitance				470		pF
C_{rss}	Reverse Transfer Capacitance				11		pF
R_g	Gate resistance	f=1MHz		0.3	0.6	0.9	Ω
SWITCH	ING PARAMETERS		•		-		-
Q _g (10V)	Total Gate Charge				25	50	nC
Q_{gs}	Gate Source Charge	V _{GS} =10V, V _{DS} =40V,	V _{GS} =10V, V _{DS} =40V, I _D =17A		9		nC
Q_{gd}	Gate Drain Charge	1			4.2		nC
Q _{oss}	Output Charge	$V_{GS}=0V$, $V_{DS}=40V$			36		nC
t _{D(on)}	Turn-On DelayTime				10		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_L =2.78 Ω , R_{GEN} =3 Ω			4		ns
$t_{D(off)}$	Turn-Off DelayTime				21		ns
t _f	Turn-Off Fall Time				4		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =17A, di/dt=500A/μs			28		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =17A, di/dt=500A/μs			140		nC

A. The value of R_{0JA} is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{0JA} 1≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}\!\!=\!\!150^\circ\,$ C.

D. The R_{BJA} is the sum of the thermal impedance from junction to case R_{BJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

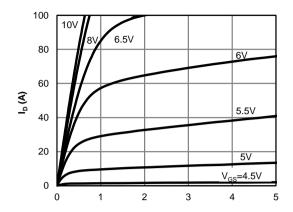
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=150^{\circ}$ C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

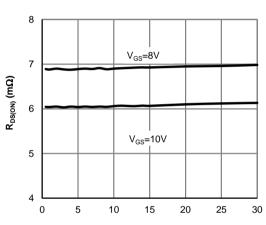
H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C.



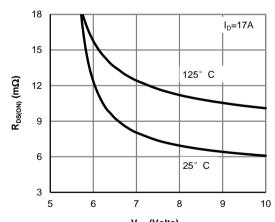
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



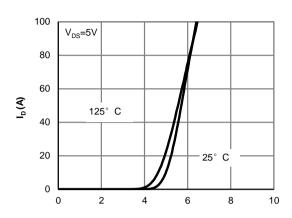
V_{DS} (Volts) Figure 1: On-Region Characteristics (Note E)



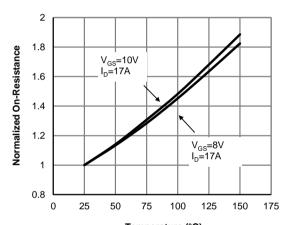
I_D (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



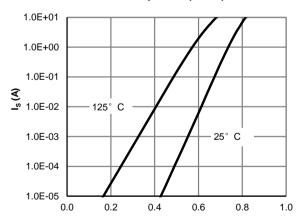
V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)



V_{GS} (Volts)
Figure 2: Transfer Characteristics (Note E)



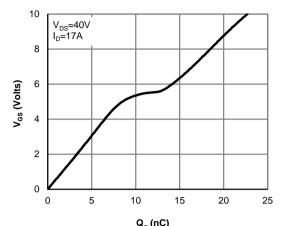
Temperature (°C)
Figure 4: On-Resistance vs. Junction
Temperature (Note E)



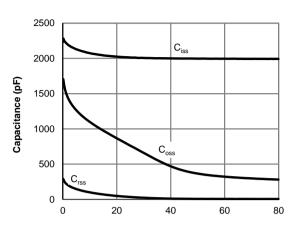
V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 $\mathbf{Q_g} \text{ (nC)}$ Figure 7: Gate-Charge Characteristics



 V_{DS} (Volts) Figure 8: Capacitance Characteristics

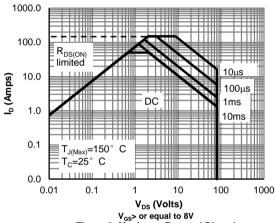
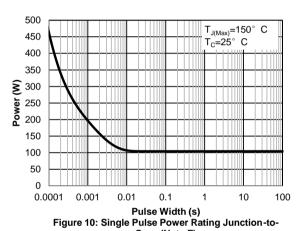
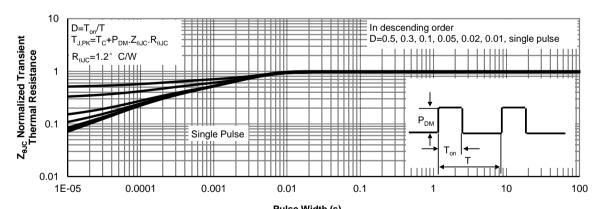


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)



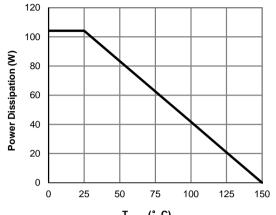
Case (Note F)



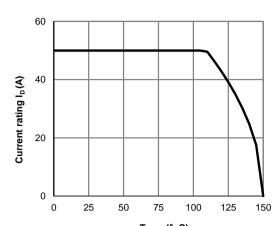
Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



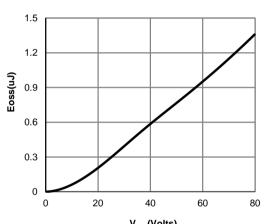
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



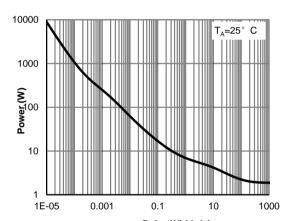
T_{CASE} (° C)
Figure 12: Power De-rating (Note F)



T_{CASE} (° C) Figure 13: Current De-rating (Note F)



V_{DS} (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note H)

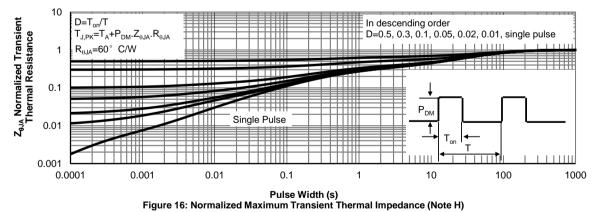


Figure A: Gate Charge Test Circuit & Waveforms

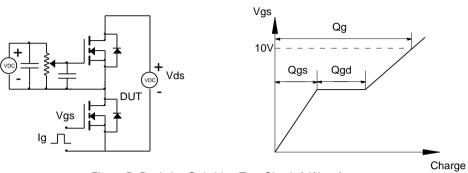


Figure B: Resistive Switching Test Circuit & Waveforms

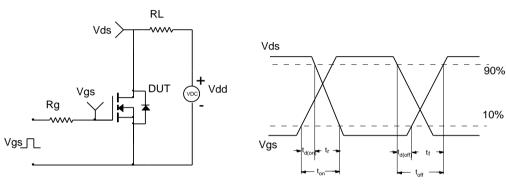


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

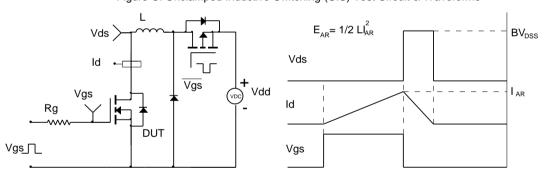


Figure D: Diode Recovery Test Circuit & Waveforms

